

**International Journal of Current  
Microbiology and Applied Sciences  
(IJCMAS) NAAS RATING-5.38, ICV-95.39**  
**ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)**

**An International, Monthly, Online, Free Access, Peer Reviewed,  
Indexed, fast track Scientific Research Journal**

**Certificate of Publication**

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2017.6.(10):3592-3599

<https://doi.org/10.20546/ijcmas.2017.610.423>

Genetic Studies on the Effect of Slow Rusting Genes Lr34 and Lr68 on Minimizing Grain Yield Losses in Back Cross Segregating Populations of the Cross GW322 X Parula in Bread Wheat (*Triticum aestivum* L.)

Ashutosh Kumar<sup>1</sup>, S.A. Desai<sup>1\*</sup>, Suma S. Biradar<sup>2</sup>, K.J. Yashavantha Kumar<sup>3</sup>, P.V. Patil<sup>2</sup>, V. Rudra Naik<sup>2</sup>, T.N. Sathisha<sup>1</sup> and Bhumika N. Patel<sup>1</sup>

<sup>1</sup>Department of Genetics and Plant Breeding

<sup>2</sup>ICAR-AICRP on Wheat, MARS, University of Agricultural Sciences, Dharwad-580005, Karnataka, India

<sup>3</sup>Agharkar Research Institute, Pune, India



*Dr. M. Prakash*  
*Editor-in-chief*

*International Journal of Current Microbiology and Applied Sciences*

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